

NB3V8312C

Ultra-Low Jitter, Low Skew 1:12 LVCMOS/LVTTL Fanout Buffer

The NB3V8312C is a high performance, low skew LVCMOS fanout buffer which can distribute 12 ultra-low jitter clocks from an LVCMOS/LVTTL input up to 250 MHz.

The 12 LVCMOS output pins drive 50 Ω series or parallel terminated transmission lines. The outputs can also be disabled to a high impedance (tri-stated) via the OE input, or enabled when High.

The NB3V8312C provides an enable input, CLK_EN pin, which synchronously enables or disables the clock outputs while in the LOW state. Since this input is internally synchronized to the input clock, changing only when the input is LOW, potential output glitching or runt pulse generation is eliminated.

Separate V_{DD} core and V_{DDO} output supplies allow the output buffers to operate at the same supply as the V_{DD} ($V_{DD} = V_{DDO}$) or from a lower supply voltage. Compared to single-supply operation, dual supply operation enables lower power consumption and output-level compatibility.

The V_{DD} core supply voltage can be set to 3.3 V, 2.5 V or 1.8 V, while the V_{DDO} output supply voltage can be set to 3.3 V, 2.5 V, or 1.8 V, with the constraint that $V_{DD} \geq V_{DDO}$.

This buffer is ideally suited for various networking, telecom, server and storage area networking, RRU LO reference distribution, medical and test equipment applications.

Features

- Power Supply Modes:
 V_{DD} (Core) / V_{DDO} (Outputs)
3.3 V / 3.3 V
3.3 V / 2.5 V
3.3 V / 1.8 V
2.5 V / 2.5 V
2.5 V / 1.8 V
1.8 V / 1.8 V
- 250 MHz Maximum Clock Frequency
- Accepts LVCMOS, LVTTL Clock Inputs
- LVCMOS Compatible Control Inputs
- 12 LVCMOS Clock Outputs
- Synchronous Clock Enable
- Output Enable to High Z State Control
- 150 ps Max. Skew Between Outputs
- Temp. Range -40°C to $+85^{\circ}\text{C}$
- 32-pin LQFP and QFN Packages
- These are Pb-Free Devices

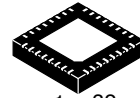


ON Semiconductor®

<http://onsemi.com>



LQFP-32
FA SUFFIX
CASE 873A



QFN32
MN SUFFIX
CASE 488AM

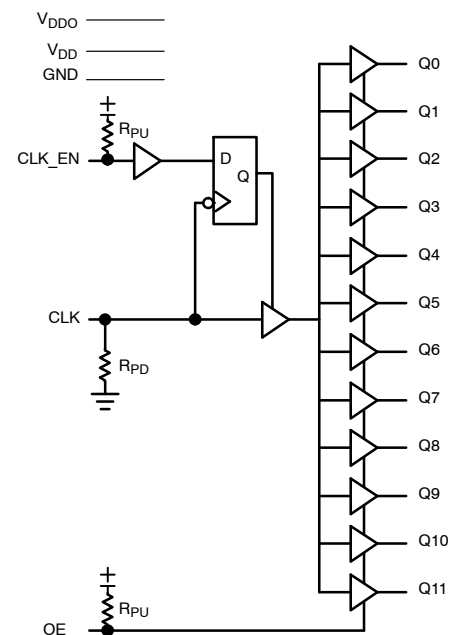


Figure 1. Simplified Logic Diagram

ORDERING AND MARKING INFORMATION

See detailed ordering and shipping information on page 9 of this data sheet.

Applications

- Networking
- Telecom
- Storage Area Network

End Products

- Servers
- Routers
- Switches

NB3V8312C

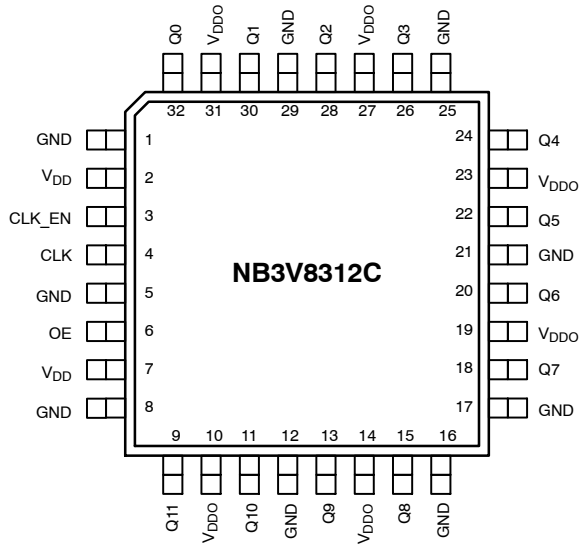


Figure 2. LQFP-32 Pinout Configuration
(Top View)

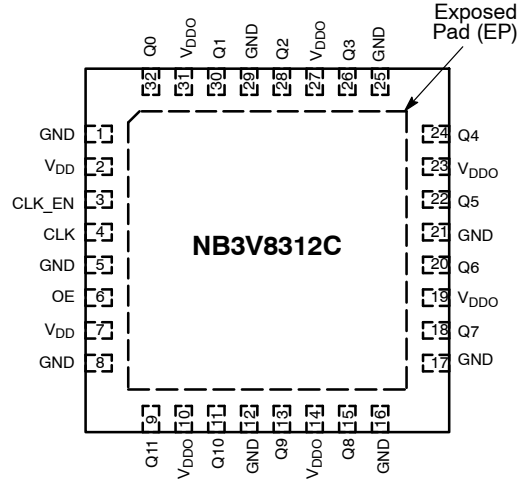


Figure 3. QFN32 Pinout Configuration
(Top View)

Table 1. PIN DESCRIPTION

| Pin | Name | I/O | Open Default | Description |
|---|--|--------|--------------|---|
| 1, 5, 8, 12, 16, 17, 21, 25, 29 | GND | Power | | Ground, Negative Power Supply |
| 2, 7 | VDD | Power | | Positive Supply for Core and Inputs |
| 3 | CLK_EN | Input | High | Synchronous Clock Enable Input. When High, outputs are enabled. When Low, outputs are disabled Low. Internal Pullup Resistor. |
| 4 | CLK | Input | Low | Single-ended Clock input; LVCMOS/LVTTL. Internal Pull-down Resistor. |
| 6 | OE | Input | High | Output Enable. Internal Pullup Resistor. |
| 9, 11, 13, 15, 18, 20, 22, 24, 26, 28, 30, 32 | Q11, Q10, Q9, Q8, Q7, Q6, Q5, Q4, Q3, Q2, Q1, Q0 | Output | | Single-ended LVCMOS/LVTTL outputs |
| 10, 14, 19, 23, 27, 31 | VDD0 | Power | | Positive Supply for Outputs |
| - | EP | - | - | The Exposed Pad (EP) on the package bottom is thermally connected to the die for improved heat transfer out of package. The exposed pad must be attached to a heat-sinking conduit. The pad is connected to the die and must only be connected electrically to GND on the PC board. |

- All VDD, VDD0 and GND pins must be externally connected to a power supply to guarantee proper operation. Bypass each supply pin with 0.01 μ F to GND.

NB3V8312C

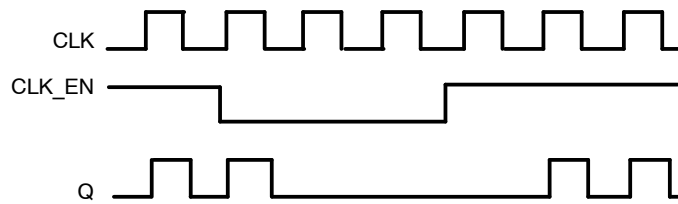


Figure 4. CLK_EN Control Timing Diagram

Table 2. OE, CLK_EN FUNCTION TABLES

| Inputs | | | Outputs |
|--------|-----------------|-----|---------|
| OE | CLK_EN (Note 2) | CLK | Q[0:11] |
| 0 | X | X | Hi-Z |
| 1 | 0 | X | Low |
| 1 | 1 | 0 | Low |
| 1 | 1 | 1 | High |

2. The CLK_EN control input synchronously enables or disables the outputs as shown in Figure 4. This control latches on the falling edge of the selected input CLK. When CLK_EN is LOW, the outputs are disabled in a LOW state. When CLK_EN is HIGH, the outputs are enabled as shown. CLK_EN to CLK Set up and Hold times must be satisfied.

NB3V8312C

Table 3. ATTRIBUTES (Note 3)

| Characteristics | Value |
|---|-----------------------------------|
| Internal Input Pullup (R_{PU}) and Pulldown (R_{PD}) Resistor | 50 k Ω |
| Input Capacitance, C_{IN} | 4 pF |
| Power Dissipation Capacitance, C_{PD} (per Output) | 20 pF |
| R_{OUT} | 8 Ω |
| ESD Protection | Human Body Model Machine Model |
| | > 1.5 kV > 200 V |
| Moisture Sensitivity, Indefinite Time Out of Drypack (Note 3) | Level 1 |
| Flammability Rating Oxygen Index | UL-94 code V-0 A 1/8" 28 to 34 |
| Transistor Count | 464 Devices |
| Meets or exceeds JEDEC Spec EIA/JESD78 IC Latchup Test | |

3. For additional information, see Application Note AND8003/D.

Table 4. MAXIMUM RATINGS (Note 4)

| Symbol | Parameter | Condition | | Rating | Unit |
|--------------------|--|--------------------|--------------------|-----------------------------------|--|
| V_{DD} / V_{DDO} | Positive Power Supply | GND = 0 V | | 4.6 | V |
| V_I | Input Voltage | | | $-0.5 \leq V_I \leq V_{DD} + 0.5$ | V |
| T_{stg} | Storage Temperature Range | | | -65 to +150 | $^{\circ}\text{C}$ |
| θ_{JA} | Thermal Resistance (Junction-to-Ambient) (Note 5) | 0 lfpm 500 lfpm | LQFP-32 LQFP-32 | 80 55 | $^{\circ}\text{C}/\text{W}$ $^{\circ}\text{C}/\text{W}$ |
| θ_{JC} | Thermal Resistance (Junction-to-Case) (Note 5) | Standard Board | LQFP-32 LQFP-32 | 12-17 | $^{\circ}\text{C}/\text{W}$ |
| θ_{JA} | Thermal Resistance (Junction-to-Ambient) (Note 5) | 0 lfpm 500 lfpm | QFN-32 QFN-32 | 31 27 | $^{\circ}\text{C}/\text{W}$ |
| θ_{JC} | Thermal Resistance (Junction-to-Case) (Note 5) | Standard Board | QFN-32 | 12 | $^{\circ}\text{C}/\text{W}$ |

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

- Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and not valid simultaneously. If stress limits are exceeded device functional operation is not implied, damage may occur and reliability may be affected.
- JEDEC standard multilayer board – 2S2P (2 signal, 2 power).

NB3V8312C

Table 5. LVCMOS/LVTTL DC CHARACTERISTICS ($T_A = -40^{\circ}\text{C}$ to $+85^{\circ}\text{C}$)

| Symbol | Characteristics | | Conditions | Min | Typ | Max | Unit |
|----------|------------------------------|------------|---|----------------------|-----|----------------------|---------------|
| V_{IH} | Input High Voltage | | $V_{DD} = 3.465\text{ V}$ | 2.0 | | $V_{DD} + 0.3$ | V |
| | | | $V_{DD} = 2.625\text{ V}$ | 1.7 | | $V_{DD} + 0.3$ | V |
| | | | $V_{DD} = 2.0\text{ V}$ | $0.65 \times V_{DD}$ | | $V_{DD} + 0.3$ | V |
| V_{IL} | Input Low Voltage | | $V_{DD} = 3.465\text{ V}$ | -0.3 | | 1.3 | V |
| | | | $V_{DD} = 2.625\text{ V}$ | -0.3 | | 0.7 | V |
| | | | $V_{DD} = 2.0\text{ V}$ | -0.3 | | $0.35 \times V_{DD}$ | V |
| I_{IH} | Input High Current | CLK | $V_{DD} = V_{IN} = 3.465\text{ V}$ or 2.625 V or 2.0 V | | | 150 | μA |
| | | OE, CLK_EN | | 5 | | | |
| I_{IL} | Input Low Current | CLK | $V_{DD} = 3.465\text{ V}$ or 2.625 V or 2.0 V , $V_{IN} = 0\text{ V}$ | -5 | | | μA |
| | | OE, CLK_EN | | -150 | | | |
| V_{OH} | Output High Voltage (Note 6) | | $V_{DDO} = 3.3\text{ V} \pm 5\%$ | 2.6 | | | V |
| | | | $V_{DDO} = 2.5\text{ V} \pm 5\%$ | 1.8 | | | |
| | | | $V_{DDO} = 2.5\text{ V} \pm 5\%$; $I_{OH} = -1\text{ mA}$ | 2.0 | | | |
| | | | $V_{DDO} = 1.8\text{ V} \pm 0.2\text{ V}$ | $V_{DD} - 0.4$ | | | |
| | | | $V_{DDO} = 1.8\text{ V} \pm 0.2\text{ V}$; $I_{OH} = -100\ \mu\text{A}$ | $V_{DD} - 0.2$ | | | |
| V_{OL} | Output Low Voltage (Note 6) | | $V_{DDO} = 3.3\text{ V} \pm 5\%$ | | | 0.5 | V |
| | | | $V_{DDO} = 2.5\text{ V} \pm 5\%$ | | | 0.45 | |
| | | | $V_{DDO} = 2.5\text{ V} \pm 5\%$; $I_{OL} = 1\text{ mA}$ | | | 0.4 | |
| | | | $V_{DDO} = 1.8\text{ V} \pm 0.2\text{ V}$ | | | 0.35 | |
| | | | $V_{DDO} = 1.8\text{ V} \pm 0.2\text{ V}$; $I_{OL} = 100\ \mu\text{A}$ | | | 0.2 | |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

6. Outputs terminated $50\ \Omega$ to $V_{DDO}/2$ unless otherwise specified. See Figure 7.

Table 6. POWER SUPPLY DC CHARACTERISTICS, ($T_A = -40^{\circ}\text{C}$ to $+85^{\circ}\text{C}$)

| V_{DD} (Core) | V_{DDO} (Outputs) | Min | Typ | Max | Unit |
|---------------------------------|---------------------------------|-----|-----|-----|------|
| $3.3\text{ V} \pm 5\%$ | $3.3\text{ V} \pm 5\%$ | | | 10 | mA |
| $3.3\text{ V} \pm 5\%$ | $2.5\text{ V} \pm 5\%$ | | | 10 | mA |
| $3.3\text{ V} \pm 5\%$ | $1.8\text{ V} \pm 0.2\text{ V}$ | | | 10 | mA |
| $2.5\text{ V} \pm 5\%$ | $2.5\text{ V} \pm 5\%$ | | | 10 | mA |
| $2.5\text{ V} \pm 5\%$ | $1.8\text{ V} \pm 0.2\text{ V}$ | | | 10 | mA |
| $1.8\text{ V} \pm 0.2\text{ V}$ | $1.8\text{ V} \pm 0.2\text{ V}$ | | | 10 | mA |

NB3V8312C

Table 7. AC CHARACTERISTICS ($T_A = -40^\circ\text{C}$ to $+85^\circ\text{C}$) (Note 7)

| Symbol | Characteristic | Min | Typ | Max | Unit |
|---------------------|---|---|------------------------------------|---|------|
| f_{MAX} | Maximum Operating Frequency $V_{\text{DD}} / V_{\text{DDO}}$ 3.3 V $\pm 5\%$ / 3.3 V $\pm 5\%$ 3.3 V $\pm 5\%$ / 2.5 V $\pm 5\%$ 3.3 V $\pm 5\%$ / 1.8 V ± 0.2 V 2.5 V $\pm 5\%$ / 2.5 V $\pm 5\%$ 2.5 V $\pm 5\%$ / 1.8 V ± 0.2 V 1.8 V ± 0.2 V / 1.8 V ± 0.2 V | 250 250 200 250 200 200 | | | MHz |
| t_{pLH} | Propagation Delay, Low to High; (Note 8) $V_{\text{DD}} / V_{\text{DDO}}$ 3.3 V $\pm 5\%$ / 3.3 V $\pm 5\%$ 3.3 V $\pm 5\%$ / 2.5 V $\pm 5\%$ 3.3 V $\pm 5\%$ / 1.8 V ± 0.2 V 2.5 V $\pm 5\%$ / 2.5 V $\pm 5\%$ 2.5 V $\pm 5\%$ / 1.8 V ± 0.2 V 1.8 V ± 0.2 V / 1.8 V ± 0.2 V | 0.9 1.0 1.0 1.3 1.3 2.4 | | 2.2 2.3 3.0 3.1 3.5 4.2 | ns |
| t_{jit} | Additive Phase Jitter, RMS; $f_C = 100$ MHz Integration Range: 12 kHz – 20 MHz See Figure 5 $V_{\text{DD}} / V_{\text{DDO}}$ 3.3 V $\pm 5\%$ / 3.3 V $\pm 5\%$ 3.3 V $\pm 5\%$ / 2.5 V $\pm 5\%$ 3.3 V $\pm 5\%$ / 1.8 V ± 0.2 V 2.5 V $\pm 5\%$ / 2.5 V $\pm 5\%$ 2.5 V $\pm 5\%$ / 1.8 V ± 0.2 V 1.8 V ± 0.2 V / 1.8 V ± 0.2 V | | 30 40 50 20 100 130 | | fs |
| $t_{\text{sk(o)}}$ | Output-to-output skew; (Note 9); Figure 6 $V_{\text{DD}} / V_{\text{DDO}}$ 3.3 V $\pm 5\%$ / 3.3 V $\pm 5\%$ 3.3 V $\pm 5\%$ / 2.5 V $\pm 5\%$ 3.3 V $\pm 5\%$ / 1.8 V ± 0.2 V 2.5 V $\pm 5\%$ / 2.5 V $\pm 5\%$ 2.5 V $\pm 5\%$ / 1.8 V ± 0.2 V 1.8 V ± 0.2 V / 1.8 V ± 0.2 V | | | 125 135 145 150 150 140 | ps |
| $t_{\text{sk(pp)}}$ | Part-to-Part Skew; (Note 10) $V_{\text{DD}} / V_{\text{DDO}}$ 3.3 V $\pm 5\%$ / 3.3 V $\pm 5\%$ 3.3 V $\pm 5\%$ / 2.5 V $\pm 5\%$ 3.3 V $\pm 5\%$ / 1.8 V ± 0.2 V 2.5 V $\pm 5\%$ / 2.5 V $\pm 5\%$ 2.5 V $\pm 5\%$ / 1.8 V ± 0.2 V 1.8 V ± 0.2 V / 1.8 V ± 0.2 V | | | 250 250 250 250 250 250 | ps |
| t_r/t_f | Output rise and fall times $V_{\text{DD}} / V_{\text{DDO}}$ 3.3 V $\pm 5\%$ / 3.3 V $\pm 5\%$ 3.3 V $\pm 5\%$ / 2.5 V $\pm 5\%$ 3.3 V $\pm 5\%$ / 1.8 V ± 0.2 V 2.5 V $\pm 5\%$ / 2.5 V $\pm 5\%$ 2.5 V $\pm 5\%$ / 1.8 V ± 0.2 V 1.8 V ± 0.2 V / 1.8 V ± 0.2 V | 200 200 200 200 200 200 200 | | 700 700 700 700 700 700 800 | ps |
| ODC | Output Duty Cycle (Note 11) $V_{\text{DD}} / V_{\text{DDO}}$ $f \leq 200$ MHz, 3.3 V $\pm 5\%$ / 3.3 V $\pm 5\%$ $f \leq 150$ MHz, 3.3 V $\pm 5\%$ / 2.5 V $\pm 5\%$ $f \leq 100$ MHz, 3.3 V $\pm 5\%$ / 1.8 V ± 0.2 V $f \leq 150$ MHz, 2.5 V $\pm 5\%$ / 2.5 V $\pm 5\%$ $f \leq 100$ MHz, 2.5 V $\pm 5\%$ / 1.8 V ± 0.2 V $f \leq 100$ MHz, 1.8 V ± 0.2 V / 1.8 V ± 0.2 V | 45 45 45 45 45 45 | | 55 55 55 55 55 55 | % |

All parameters measured at f_{MAX} unless noted otherwise.

7. Outputs loaded with 50 Ω to $V_{\text{DDO}}/2$; see Figure 7. CLOCK input with 50% duty cycle; minimum input amplitude = 1.2 V at $V_{\text{DD}} = 3.3$ V, 1.0 V at $V_{\text{DD}} = 2.5$ V, $V_{\text{DD}}/2$ at $V_{\text{DD}} = 1.8$ V.

8. Measured from the $V_{\text{DD}}/2$ of the input to $V_{\text{DDO}}/2$ of the output.

9. Defined as skew between outputs at the same supply voltage and with equal load conditions. Measured at $V_{\text{DDO}}/2$.

10. Defined as skew between outputs on different devices operating at the same supply voltage and with equal load conditions.

Using the same type of input on each device, the output is measured at $V_{\text{DDO}}/2$.

11. Clock input with 50% duty cycles, rail-to-rail amplitude and $t_r/t_f = 500$ ps.

NB3V8312C

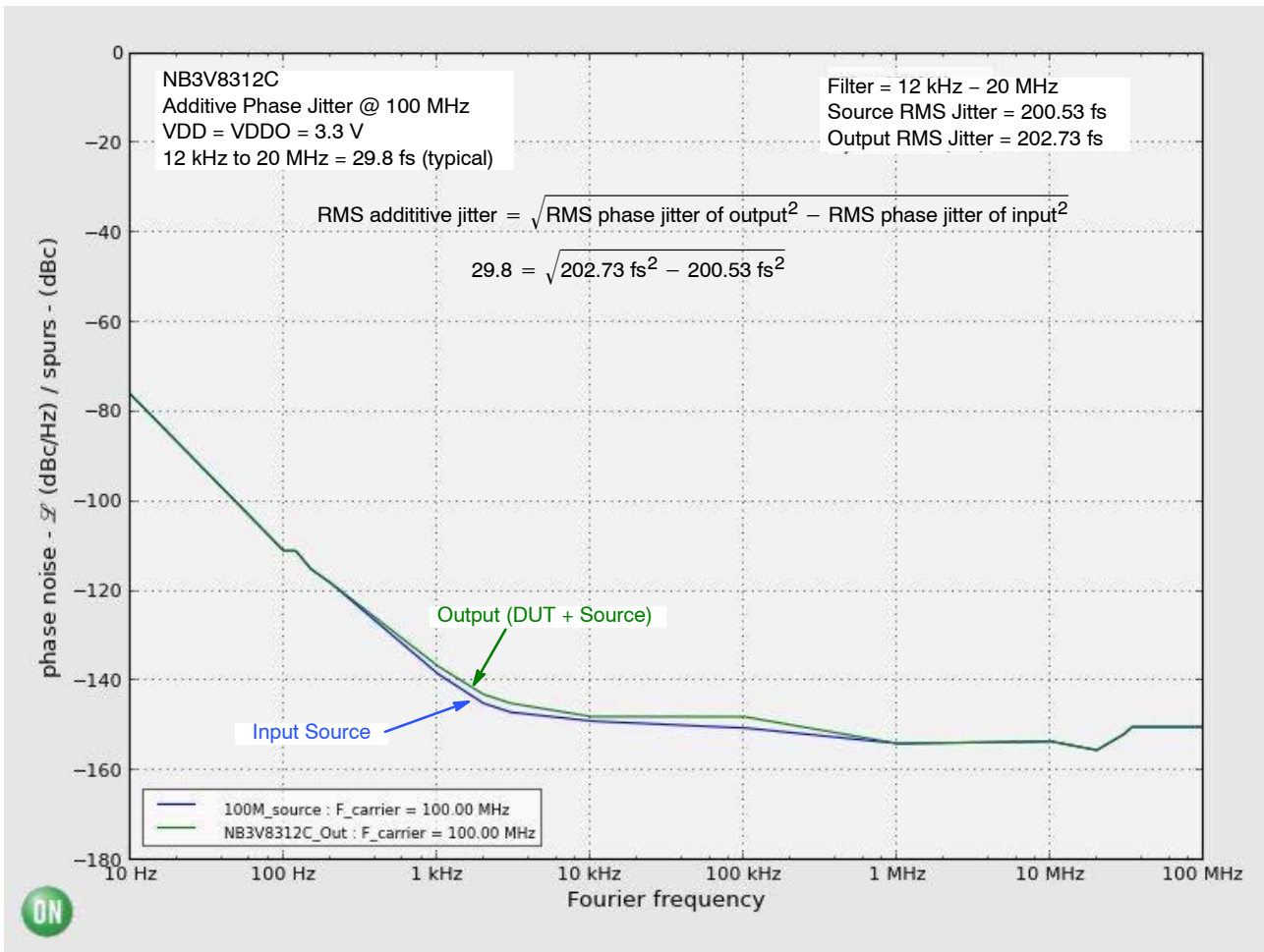


Figure 5. Typical Phase Noise Plot at $f_{\text{carrier}} = 100 \text{ MHz}$ at an Operating Voltage of 3.3 V, Room Temperature

The above phase noise data was captured using Agilent E5052A/B. The data displays the input phase noise and output phase noise used to calculate the additive phase jitter at a specified integration range. The RMS Phase Jitter contributed by the device (integrated between 12 kHz and 20 MHz) is 29.8 fs.

The additive phase jitter performance of the fanout buffer is highly dependent on the phase noise of the input source.

To obtain the most accurate additive phase noise measurement, it is vital that the source phase noise be

notably lower than that of the DUT. If the phase noise of the source is greater than the device under test output, the source noise will dominate the additive phase jitter calculation and lead to an artificially low result for the additive phase noise measurement within the integration range. The Figure above is a good example of the NB3V8312C source generator phase noise having a significantly higher floor such that the DUT output results in an additive phase jitter of 29.8 fs.

$$\text{RMS additive jitter} = \sqrt{\text{RMS phase jitter of output}^2 - \text{RMS phase jitter of input}^2}$$

$$29.8 = \sqrt{202.73 \text{ fs}^2 - 200.53 \text{ fs}^2}$$

NB3V8312C

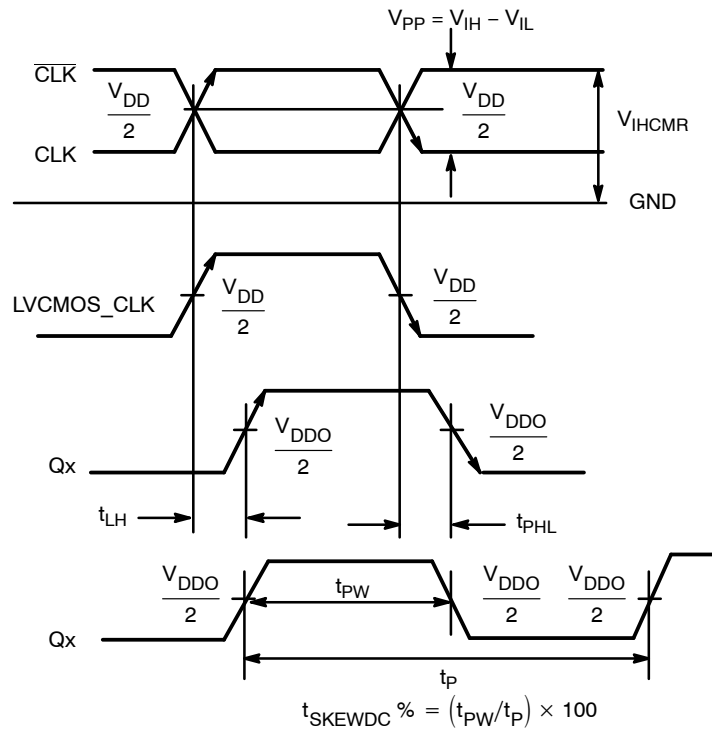


Figure 6. AC Reference Measurement

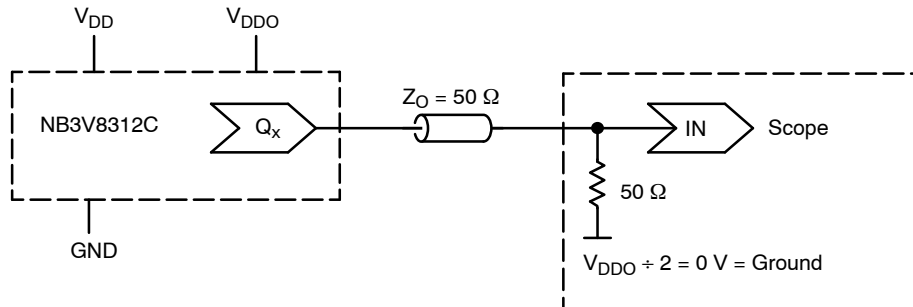


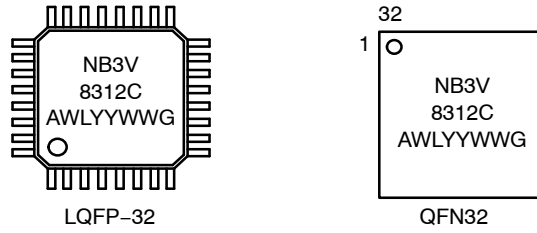
Figure 7. Typical Device Evaluation and Termination Setup – See Table 8

Table 8. TEST SUPPLY SETUP. V_{DDO} SUPPLY MAY BE CENTERED ON 0.0 V (SCOPE GND) TO PERMIT DIRECT CONNECTION INTO “50 Ω TO GND” SCOPE MODULE. V_{DD} SUPPLY TRACKS DUT GND PIN

| Spec Condition: | V _{DD} Test Setup | V _{DDO} Test Setup | GND Pin Test Setup |
|---|----------------------------|-----------------------------|--------------------|
| V _{DD} = 3.3 V ±5%, V _{DDO} = 3.3 V ±5% | +1.65 V ±5% | +1.65 V ±5% | -1.65 V ±5% |
| V _{DD} = 3.3 V ±5%, V _{DDO} = 2.5 V ±5% | +2.05 V ±5% | +1.25 V ±5% | -1.25 V ±5% |
| V _{DD} = 3.3 V ±5%, V _{DDO} = 1.8 V ±5% | +2.4 V ±5% | +0.9 V ±0.1 V | -0.9 V ±0.1 V |
| V _{DD} = 2.5 V ±5%, V _{DDO} = 2.5 V ±5% | +1.25 V ±5% | +1.25 V ±5% | -1.25 V ±5% |
| V _{DD} = 2.5 V ±5%, V _{DDO} = 1.8 V ±0.2 V | +1.6 V ±5% | +0.9 V ±0.1 V | -0.9 V ±0.1 V |
| V _{DD} = 1.8 V ±0.2 V, V _{DDO} = 1.8 V ±0.2 V | +0.9 V ±0.1 V | +0.9 V ±0.1 V | -0.9 V ±0.1 V |

NB3V8312C

MARKING DIAGRAMS*



A = Assembly Location
 WL = Wafer Lot
 YY = Year
 WW = Work Week
 G = Pb-Free Package

(*Note: Microdot may be in either location)

*For additional marking information, refer to Application Note AND8002/D.

ORDERING INFORMATION

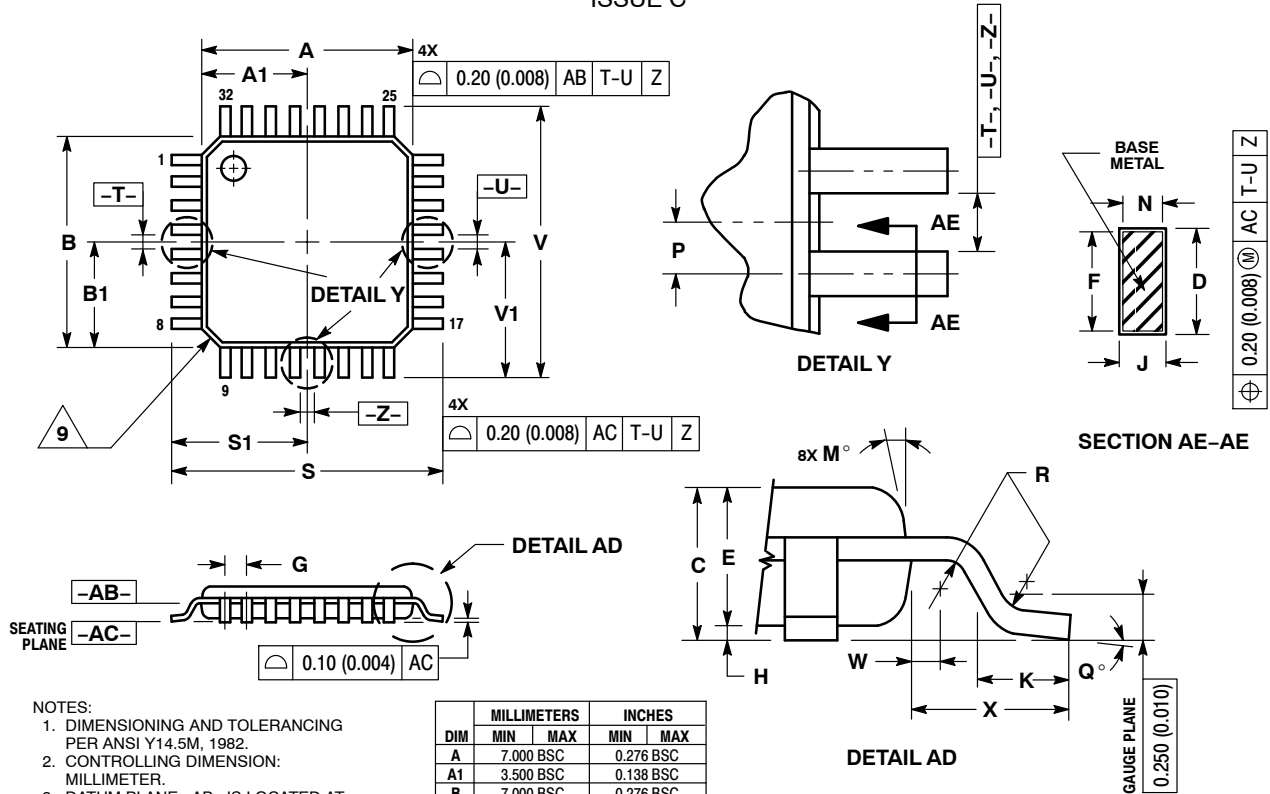
| Device | Package | Shipping [†] |
|----------------|----------------------|-----------------------|
| NB3V8312CFAG | LQFP-32 (Pb-Free) | 250 Units / Tray |
| NB3V8312CFAR2G | LQFP-32 (Pb-Free) | 2000 / Tape & Reel |
| NB3V8312CMNG | QFN32 (Pb-Free) | 74 Units / Rail |
| NB3V8312CMNR4G | QFN32 (Pb-Free) | 1000 / Tape & Reel |

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

NB3V8312C

PACKAGE DIMENSIONS

32 LEAD LQFP
CASE 873A-02
ISSUE C



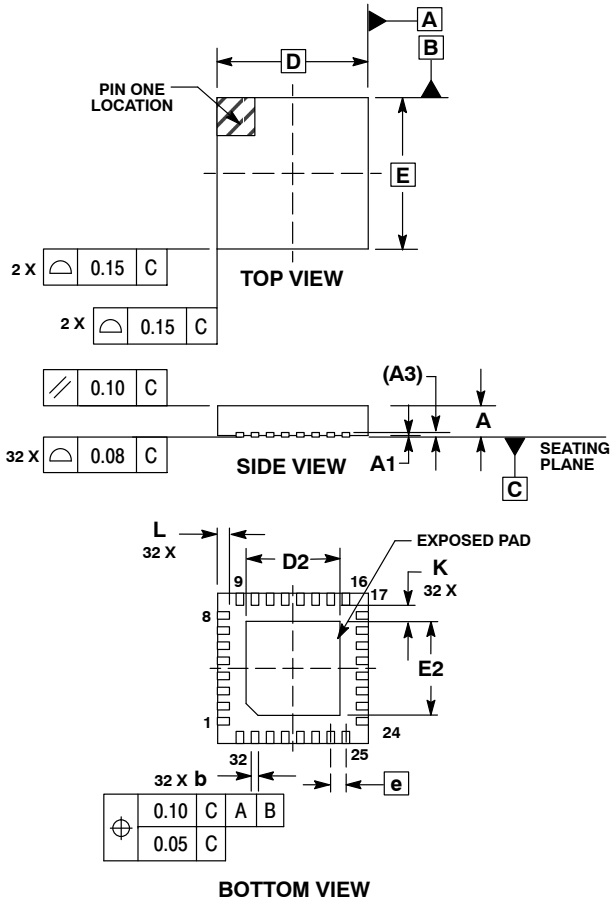
- NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: MILLIMETER.
 3. DATUM PLANE -AB- IS LOCATED AT BOTTOM OF LEAD AND IS COINCIDENT WITH THE LEAD WHERE THE LEAD EXITS THE PLASTIC BODY AT THE BOTTOM OF THE PARTING LINE.
 4. DATUMS -T-, -U-, AND -Z- TO BE DETERMINED AT DATUM PLANE -AB-.
 5. DIMENSIONS S AND V TO BE DETERMINED AT SEATING PLANE -AC-.
 6. DIMENSIONS A AND B DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSION IS 0.250 (0.010) PER SIDE. DIMENSIONS A AND B DO INCLUDE MOLD MISMATCH AND ARE DETERMINED AT DATUM PLANE -AB-.
 7. DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. DAMBAR PROTRUSION SHALL NOT CAUSE THE D DIMENSION TO EXCEED 0.520 (0.020).
 8. MINIMUM SOLDER PLATE THICKNESS SHALL BE 0.0076 (0.0003).
 9. EXACT SHAPE OF EACH CORNER MAY VARY FROM DEPICTION.

| DIM | MILLIMETERS | | INCHES | |
|-----|-------------|-------|--------|-------|
| | MIN | MAX | MIN | MAX |
| A | 7.000 | BSC | 0.276 | BSC |
| A1 | 3.500 | BSC | 0.138 | BSC |
| B | 7.000 | BSC | 0.276 | BSC |
| B1 | 3.500 | BSC | 0.138 | BSC |
| C | 1.400 | 1.600 | 0.055 | 0.063 |
| D | 0.300 | 0.450 | 0.012 | 0.018 |
| E | 1.350 | 1.450 | 0.053 | 0.057 |
| F | 0.300 | 0.400 | 0.012 | 0.016 |
| G | 0.800 | BSC | 0.031 | BSC |
| H | 0.050 | 0.150 | 0.002 | 0.006 |
| J | 0.090 | 0.200 | 0.004 | 0.008 |
| K | 0.450 | 0.750 | 0.018 | 0.030 |
| M | 12° | REF | 12° | REF |
| N | 0.090 | 0.160 | 0.004 | 0.006 |
| P | 0.400 | BSC | 0.016 | BSC |
| Q | 1° | 5° | 1° | 5° |
| R | 0.150 | 0.250 | 0.006 | 0.010 |
| S | 9.000 | BSC | 0.354 | BSC |
| S1 | 4.500 | BSC | 0.177 | BSC |
| V | 9.000 | BSC | 0.354 | BSC |
| V1 | 4.500 | BSC | 0.177 | BSC |
| W | 0.200 | REF | 0.008 | REF |
| X | 1.000 | REF | 0.039 | REF |

NB3V8312C

PACKAGE DIMENSIONS

QFN32 5x5, 0.5P
CASE 488AM
ISSUE O

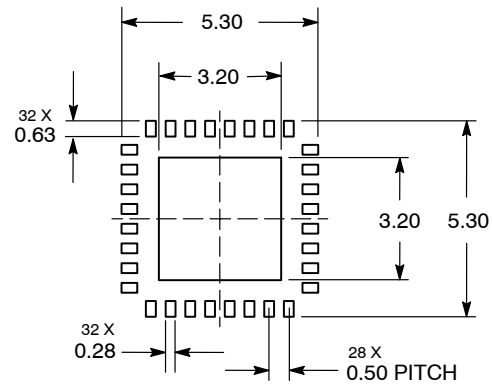


NOTES:

1. DIMENSIONS AND TOLERANCING PER ASME Y14.5M, 1994.
2. CONTROLLING DIMENSION: MILLIMETERS.
3. DIMENSION b APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.25 AND 0.30 MM TERMINAL
4. COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

| DIM | MILLIMETERS | | |
|-----|-------------|-------|-------|
| | MIN | NOM | MAX |
| A | 0.800 | 0.900 | 1.000 |
| A1 | 0.000 | 0.025 | 0.050 |
| A3 | 0.200 REF | | |
| b | 0.180 | 0.250 | 0.300 |
| D | 5.00 BSC | | |
| D2 | 2.950 | 3.100 | 3.250 |
| E | 5.00 BSC | | |
| E2 | 2.950 | 3.100 | 3.250 |
| e | 0.500 BSC | | |
| K | 0.200 | --- | --- |
| L | 0.300 | 0.400 | 0.500 |

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

ON Semiconductor and are registered trademarks of Semiconductor Components Industries, LLC (SCILLC). SCILLC owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of SCILLC's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. SCILLC reserves the right to make changes without further notice to any products herein. SCILLC makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does SCILLC assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. "Typical" parameters which may be provided in SCILLC data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. SCILLC does not convey any license under its patent rights nor the rights of others. SCILLC products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other applications intended to support or sustain life, or for any other application in which the failure of the SCILLC product could create a situation where personal injury or death may occur. Should Buyer purchase or use SCILLC products for any such unintended or unauthorized application, Buyer shall indemnify and hold SCILLC and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that SCILLC was negligent regarding the design or manufacture of the part. SCILLC is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:
Literature Distribution Center for ON Semiconductor
P.O. Box 5163, Denver, Colorado 80217 USA
Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada
Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada
Email: orderlit@onsemi.com

N. American Technical Support: 800-282-9855 Toll Free
USA/Canada
Europe, Middle East and Africa Technical Support:
Phone: 421 33 790 2910
Japan Customer Focus Center
Phone: 81-3-5817-1050

ON Semiconductor Website: www.onsemi.com
Order Literature: <http://www.onsemi.com/orderlit>
For additional information, please contact your local Sales Representative

Компания «Океан Электроники» предлагает заключение долгосрочных отношений при поставках импортных электронных компонентов на взаимовыгодных условиях!

Наши преимущества:

- Поставка оригинальных импортных электронных компонентов напрямую с производств Америки, Европы и Азии, а так же с крупнейших складов мира;
- Широкая линейка поставок активных и пассивных импортных электронных компонентов (более 30 млн. наименований);
- Поставка сложных, дефицитных, либо снятых с производства позиций;
- Оперативные сроки поставки под заказ (от 5 рабочих дней);
- Экспресс доставка в любую точку России;
- Помощь Конструкторского Отдела и консультации квалифицированных инженеров;
- Техническая поддержка проекта, помощь в подборе аналогов, поставка прототипов;
- Поставка электронных компонентов под контролем ВП;
- Система менеджмента качества сертифицирована по Международному стандарту ISO 9001;
- При необходимости вся продукция военного и аэрокосмического назначения проходит испытания и сертификацию в лаборатории (по согласованию с заказчиком);
- Поставка специализированных компонентов военного и аэрокосмического уровня качества (Xilinx, Altera, Analog Devices, Intersil, Interpoint, Microsemi, Actel, Aeroflex, Peregrine, VPT, Syfer, Eurofarad, Texas Instruments, MS Kennedy, Miteq, Cobham, E2V, MA-COM, Hittite, Mini-Circuits, General Dynamics и др.);

Компания «Океан Электроники» является официальным дистрибьютором и эксклюзивным представителем в России одного из крупнейших производителей разъемов военного и аэрокосмического назначения «JONHON», а так же официальным дистрибьютором и эксклюзивным представителем в России производителя высокотехнологичных и надежных решений для передачи СВЧ сигналов «FORSTAR».



JONHON

«JONHON» (основан в 1970 г.)

Разъемы специального, военного и аэрокосмического назначения:

(Применяются в военной, авиационной, аэрокосмической, морской, железнодорожной, горно- и нефтедобывающей отраслях промышленности)

«FORSTAR» (основан в 1998 г.)

ВЧ соединители, коаксиальные кабели, кабельные сборки и микроволновые компоненты:

(Применяются в телекоммуникациях гражданского и специального назначения, в средствах связи, РЛС, а так же военной, авиационной и аэрокосмической отраслях промышленности).



Телефон: 8 (812) 309-75-97 (многоканальный)

Факс: 8 (812) 320-03-32

Электронная почта: ocean@oceanchips.ru

Web: <http://oceanchips.ru/>

Адрес: 198099, г. Санкт-Петербург, ул. Калинина, д. 2, корп. 4, лит. А